



SHENZHEN TUOFENG SEMICONDUCTOR TECHNOLOGY CO.,LTD

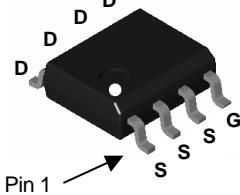
SOP-8 Plastic-Encapsulate MOSFETS

TF4402

TF4402 N-Channel Power MOSFET

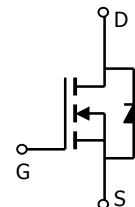
PRODUCT SUMMARY		
V _{DSS}	I _D	R _{DS(on)} (m-ohm) Typ
20V	20A	4.5@ V _{GS} = 4.5 V
		6.0@ V _{GS} = 2.5V

SO-8L



Pin 1

Equivalent Circuit



MARKING



Y :year code W :week code

Absolute Maximum Ratings T_A=25°C unless otherwise noted

Parameter	Symbol	Maximum		Units
Drain-Source Voltage	V _{DS}	20		V
Gate-Source Voltage	V _{GS}	±12		V
Continuous Drain Current ^A	I _D	20	T _A =25°C	A
Pulsed Drain Current ^B	I _{DM}	180		
Power Dissipation	P _D	3.5		W
Junction and Storage Temperature Range	T _J , T _{STG}	-55 to 150		°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	R _{θJA}	23	40	°C/W
Maximum Junction-to-Ambient ^A		48	65	°C/W
Maximum Junction-to-Lead ^C	R _{θJL}	12	16	°C/W



SHENZHEN TUOFENG SEMICONDUCTOR TECHNOLOGY CO.,LTD

SOP-8 Plastic-Encapsulate MOSFETs

TF4402

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	20			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=20\text{V}, V_{GS}=0\text{V}$			1	μA
I_{GSS}	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS} = \pm 12\text{V}$			100	nA
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	0.6	0.9	1.2	V
$I_{\text{D(ON)}}$	On state drain current	$V_{GS}=4.5\text{V}, V_{DS}=5\text{V}$	180			A
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{GS}=4.5\text{V}, I_D=20\text{A}$		4.5	5.5	$\text{m}\Omega$
		$V_{GS}=2.5\text{V}, I_D=18\text{A}$		6.0	6.9	$\text{m}\Omega$
g_{FS}	Forward Transconductance	$V_{DS}=5\text{V}, I_D=5\text{A}$	25	50		S
V_{SD}	Diode Forward Voltage	$I_S=10\text{A}, V_{GS}=0\text{V}$		0.8	1	V
I_S	Maximum Body-Diode Continuous Current				4.5	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=10\text{V}, f=1\text{MHz}$		2007		pF
C_{oss}	Output Capacitance			278		pF
C_{rss}	Reverse Transfer Capacitance			252		pF
R_g	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$		0.8		Ω
SWITCHING PARAMETERS						
Q_g	Total Gate Charge	$V_{GS}=4.5\text{V}, V_{DS}=15\text{V}, I_D=20\text{A}$		23		nC
Q_{gs}	Gate Source Charge			4		nC
Q_{gd}	Gate Drain Charge			7		nC
$t_{\text{D(on)}}$	Turn-On DelayTime	$V_{GS}=4.5\text{V}, V_{DS}=10\text{V}, ID=20\text{A}, R_{\text{GEN}}=3\Omega$		12		ns
t_r	Turn-On Rise Time			33		ns
$t_{\text{D(off)}}$	Turn-Off DelayTime			48		ns
t_f	Turn-Off Fall Time			95		ns
t_{rr}	Body Diode Reverse Recovery Time	$I_F=10\text{A}, dI/dt=100\text{A}/\mu\text{s}$		21		ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=10\text{A}, dI/dt=100\text{A}/\mu\text{s}$		11		nC

A: The value of R_{JJA} is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The value in any given application depends on the user's specific board design. The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R_{JJA} is the sum of the thermal impedance from junction to lead R_{JUL} and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using 80 μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

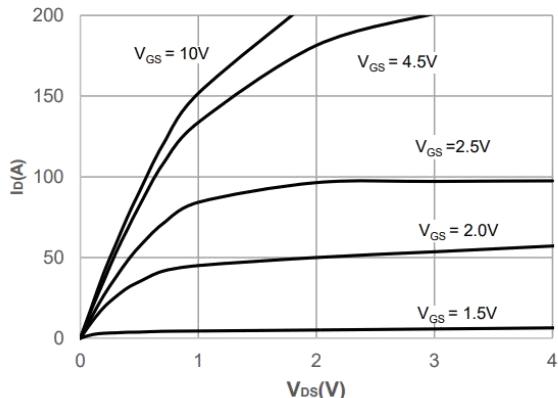


SHENZHEN TUOFENG SEMICONDUCTOR TECHNOLOGY CO.,LTD

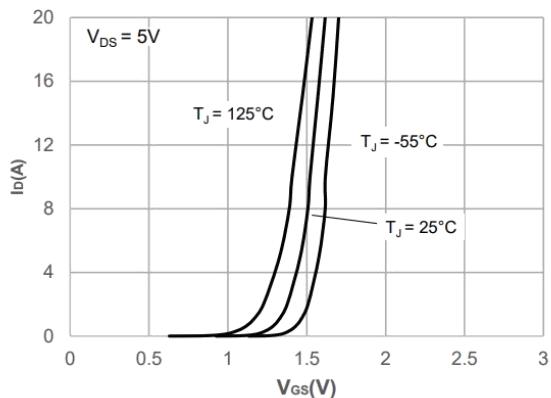
SOP-8 Plastic-Encapsulate MOSFETS

TF4402

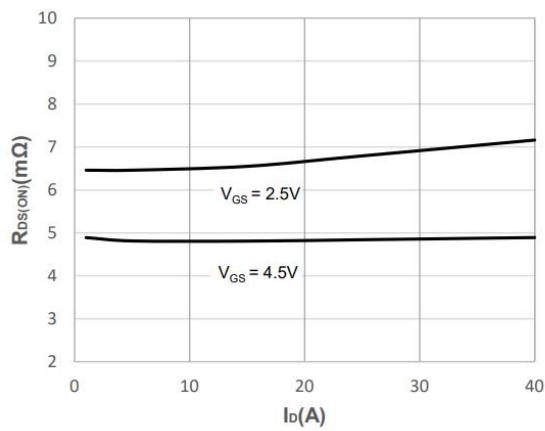
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



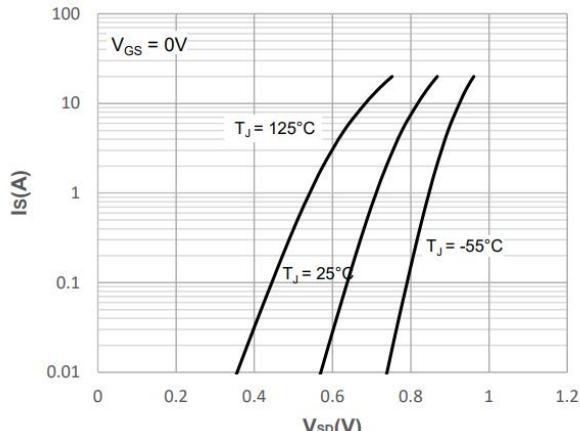
Output Characteristics



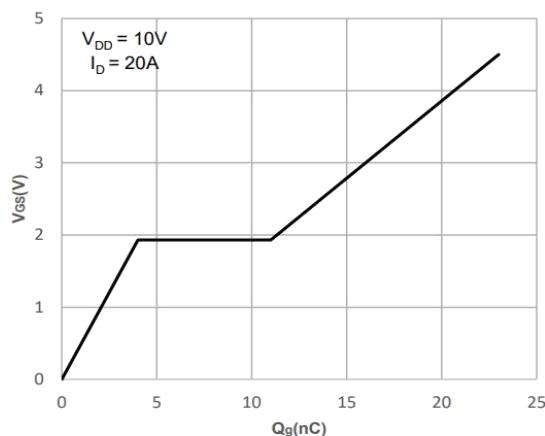
Typical Transfer Characteristics



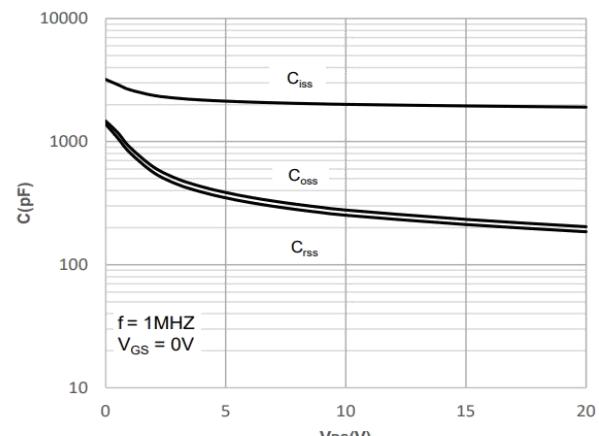
On-resistance vs. Drain Current



Body Diode Characteristics



Gate Charge Characteristics



Capacitance Characteristics

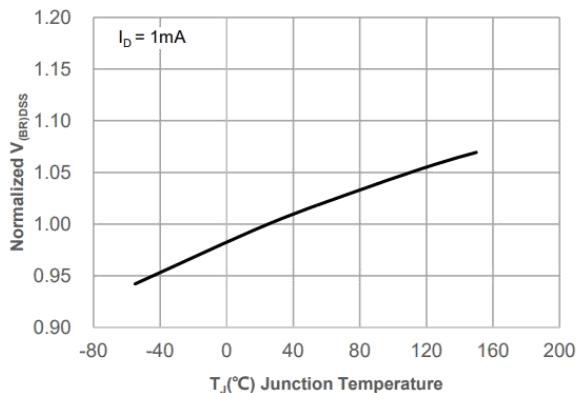


SHENZHEN TUOFENG SEMICONDUCTOR TECHNOLOGY CO., LTD

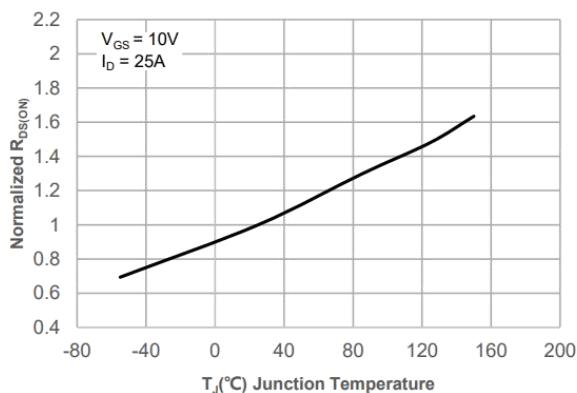
SOP-8 Plastic-Encapsulate MOSFETs

TF4402

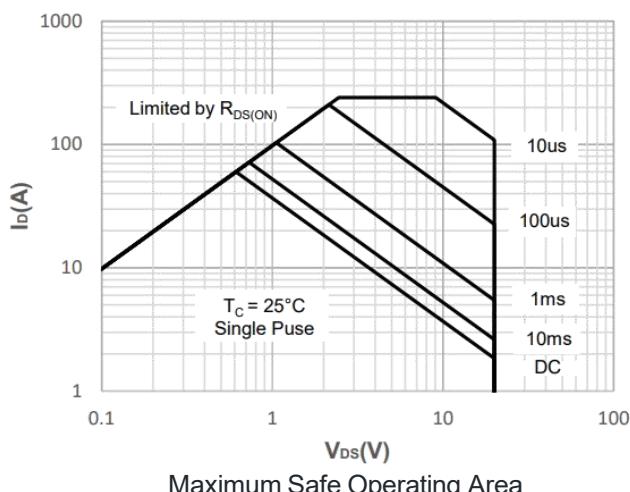
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



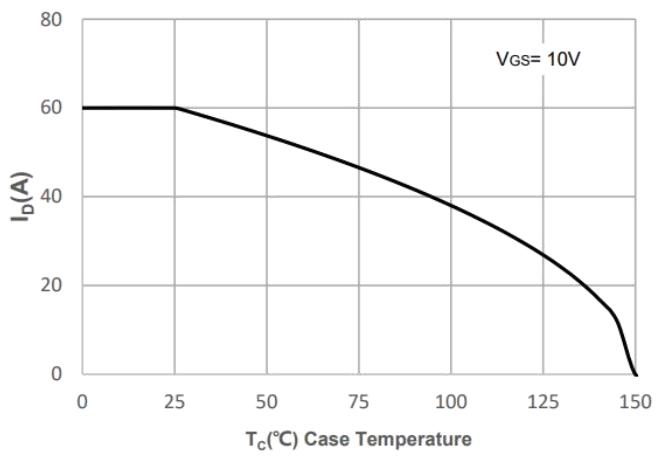
Normalized Breakdown Voltage vs.
Junction Temperature



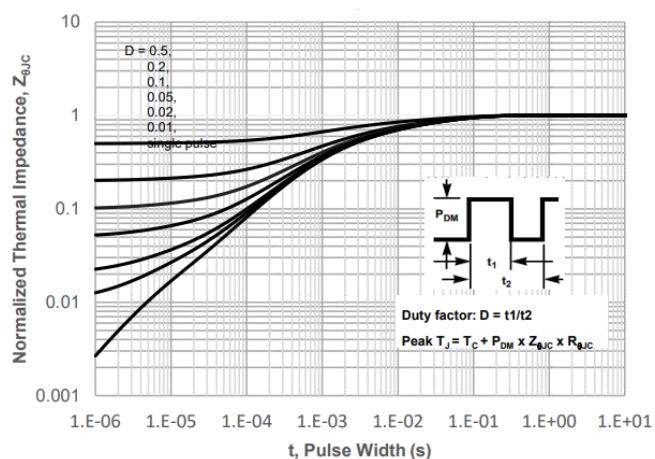
Normalized on Resistance vs.
Junction Temperature



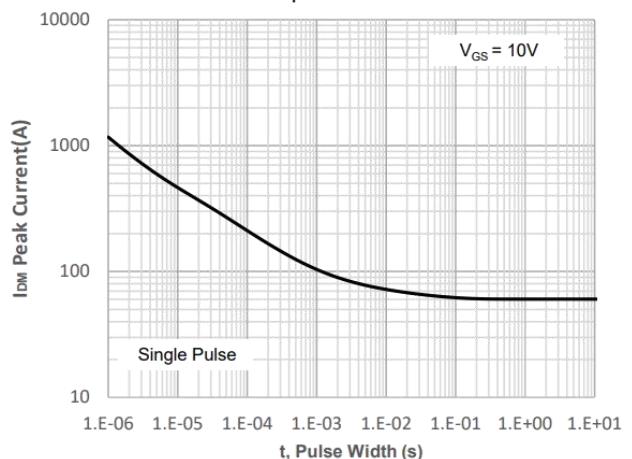
Maximum Safe Operating Area



Maximum Continuous Drain Current vs.
Case Temperature



Normalized Maximum Transient
Thermal Impedance



Peak Current Capacity

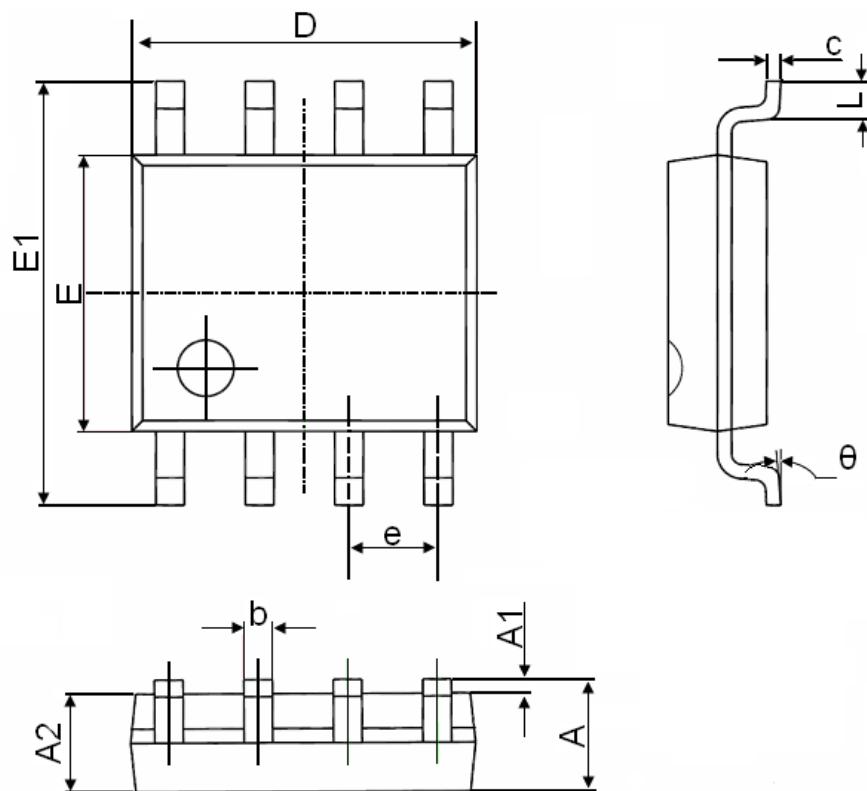


SHENZHEN TUOFENG SEMICONDUCTOR TECHNOLOGY CO.,LTD

SOP-8 Plastic-Encapsulate MOSFETs

TF4402

SOP-8 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°